Electronic Supplementary Information

Influences of pulverization and annealing treatment on photocatalytic activity of BiVO₄ for oxygen evolution

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Fig. S1 XPS spectra of BiVO₄ before and after the ball milling treatment.



Formation of defective surface

Fig. S2 Formation of defective surface by the pulverization.



Fig. S3 UV-vis spectra of BVO, BVO-BM and BVO-X.



Fig. S4 O₂ evolution using Fe³⁺ as an electron acceptor over BVO and BVO-BM-400 under white light ($\lambda > 420$ nm). Conditions: BiVO₄, 100 mg, reactant solution, 160 mL, 2 mM of an aqueous Fe(ClO₄)₃ solution at pH2.3; irradiation, 300 W Xe lamp ($\lambda > 420$ nm).



Fig. S5 TEM images of BVO-BM taken (a) immediately after the electron beam exposure and (b) after 30 seconds of (a). Acceleration voltage was 80 kV.



Fig. S6 TG-DTA curves of BVO and BVO-BM analyzed in air.



Fig. S7 (a) XRD patterns of TiO₂, TiO₂-BM and TiO₂-BM-X, (b) representative Rietveld fitting result for TiO₂-BM, (c) crystallite sizes and (d) UV-vis spectra of TiO₂, TiO₂-BM and TiO₂-BM-X.



Fig. S8 SEM images and S_{BET} of TiO₂, TiO₂-BM and TiO₂-BM-X.



Fig. S9 Comparison of EQY of TiO₂, TiO₂-BM and TiO₂-BM-400 measured at 340 and 365 nm. Conditions: sample, 100 mg; reactant solution, 2 mM of an aqueous Fe(ClO₄)₃ solution at pH2.3; irradiation, 6.6 mW at 340 nm and 11.3 mW at 365 nm.